

Electrical Characteristics (T_J=25°C unless otherwise noted)

Symbol	Parameter	Conditions		Min	Тур	Max	Units
STATIC F	PARAMETERS						
BV _{DSS}	Drain-Source Breakdown Voltage	$I_{D} = 250 \mu A, V_{GS} = 0 V$		30			V
I _{DSS}	Zero Gate Voltage Drain Current	V_{DS} = 30V, V_{GS} = 0V				1	
			T _J = 55°C			5	μA
I _{GSS}	Gate-Body leakage current	$V_{DS} = 0V, V_{GS} = \pm 16V$				±10	
V _{GS(th)}	Gate Threshold Voltage	$V_{DS} = V_{GS} I_D = 250 \mu A$		1.0	1.7	3	V
I _{D(ON)}	On state drain current	V_{GS} = 10V, V_{DS} = 5V		80			Α
R _{DS(ON)}	Static Drain-Source On-Resistance	V _{GS} = 10V, I _D = 20A			3.8	4.6	
			T _J =125°C		5.3	6.5	mΩ
		V_{GS} = 4.5V, I _D = 18A			5.2	6.4	
g _{FS}	Forward Transconductance	$V_{DS} = 5V, I_{D} = 20A$			72		S
V _{SD}	Diode Forward Voltage	$I_{\rm S}$ = 1A, $V_{\rm GS}$ = 0V			0.69	1	V
I _S	Maximum Body-Diode Continuous Curr	ent				3	Α
DYNAMIC	PARAMETERS						
C _{iss}	Input Capacitance	V _{GS} =0V, V _{DS} =15V, f=1MHz			5450	6800	pF
C _{oss}	Output Capacitance				760		pF
C _{rss}	Reverse Transfer Capacitance				540		pF
R _g	Gate resistance	V _{GS} =0V, V _{DS} =0V, f=1MHz			1	1.5	Ω
SWITCHI	NG PARAMETERS						
Q _g (10V)	Total Gate Charge	V _{GS} =10V, V _{DS} =15V, I _D =20A			84	112	nC
Q _g (4.5V)	Total Gate Charge				42	56	nC
Q _{gs}	Gate Source Charge				12		nC
Q_{gd}	Gate Drain Charge				21		nC
t _{D(on)}	Turn-On DelayTime				13		ns
t _r	Turn-On Rise Time	V_{GS} =10V, V_{DS} =15V, R_{L} =0.75 Ω , R_{GEN} =3 Ω			9.8		ns
t _{D(off)}	Turn-Off DelayTime				49		ns
t _f	Turn-Off Fall Time				16		ns
t _{rr}	Body Diode Reverse Recovery Time	I _F =20A, dI/dt=100A/μs			42	56	ns
Q _{rr}	Body Diode Reverse Recovery Charge	I _F =20A, dI/dt=100A/μs			31		nC

A: The value of R $_{0JA}$ is measured with the device mounted on 1in ² FR-4 board with 2oz. Copper, in a still air environment with T $_A$ = 25°C. The value in any given application depends on the user's specific board design. The current rating is based on the t \leq 10s thermal resistance rating.

B: Repetitive rating, pulse width limited by junction temperature.

C. The R $_{\rm \theta JA}$ is the sum of the thermal impedence from junction to lead R $_{\rm \theta JL}$ and lead to ambient.

D. The static characteristics in Figures 1 to 6 are obtained using < 300 μ s pulses, duty cycle 0.5% max.

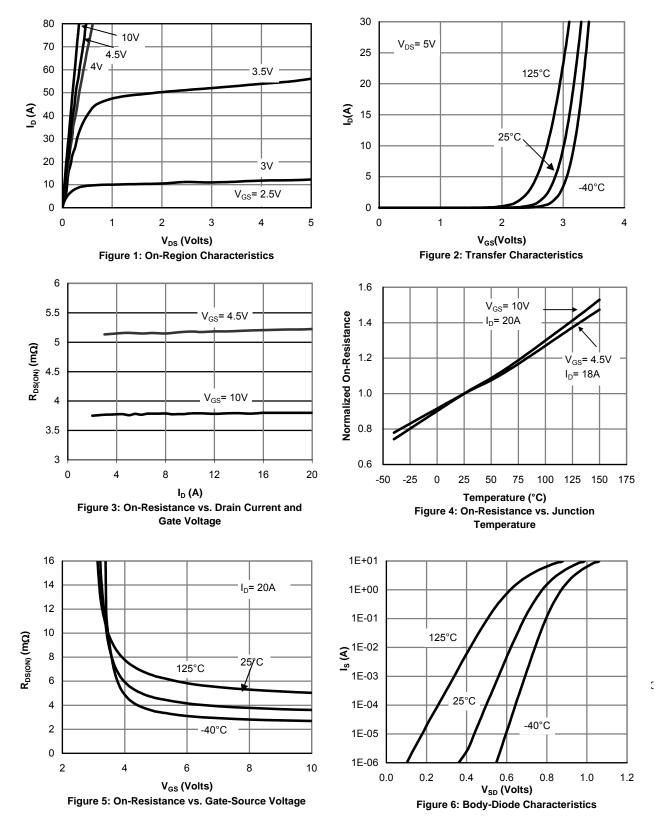
E. These tests are performed with the device mounted on 1 in 2 FR-4 board with 2oz. Copper, in a still air environment with T_A=25°C. The SOA curve provides a single pulse rating.

F. The current rating is based on the t \leq 10s thermal resistance rating.

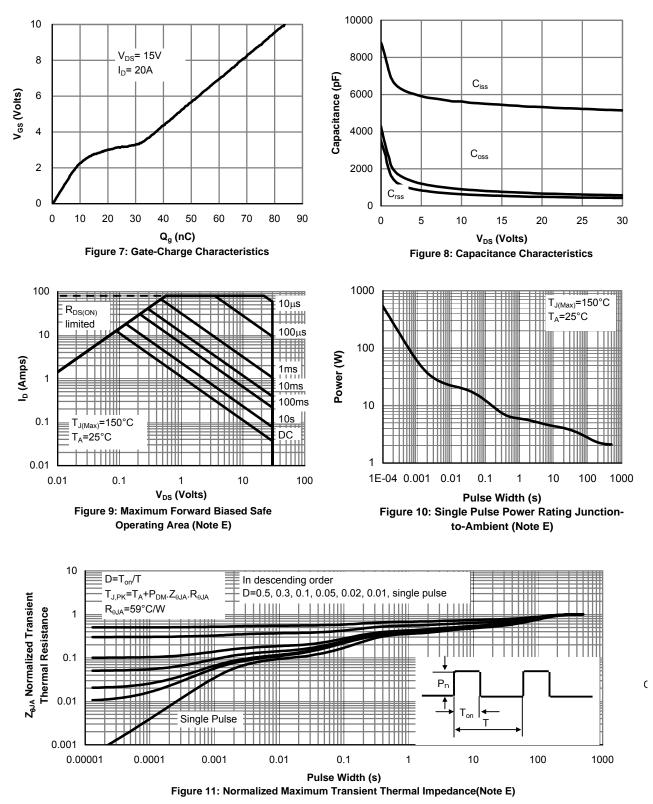
G. E_{AR} and I_{AR} ratings are based on low frequency and duty cycles to keep T_j =25C.

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TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS



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